

Benchmark Temperature Microcontroller for Process Dynamics and Control

Junho Park^a, R. Abraham Martin^a, Jeffrey D. Kelly^b, John D. Hedengren^{a,*}

^a*Department of Chemical Engineering, Brigham Young University, Provo, Utah, USA*

^b*Industrial Algorithms, 15 St. Andrews Road, Toronto, ON, Canada, M1P 4C3*

Abstract

Standard benchmarks are important repositories to establish comparisons between competing model and control methods, especially when a new method is proposed. This paper presents details of an Arduino micro-controller temperature control lab as a benchmark for modeling and control methods. As opposed to simulation studies, a physical benchmark considers real process characteristics such as the requirement to meet a cycle time, discrete sampling intervals, communication overhead with the process, and model mismatch. An example case study of the benchmark is quantifying an optimization approach for a PID controller with 5.4% improved performance. A multivariate example shows the quantified performance improvement by using model predictive control with a physics-based model, an autoregressive time series model, and a Hammerstein model with an artificial neural network to capture the static nonlinearity. These results demonstrate the potential of a hardware benchmark for transient modeling and regulatory or advanced control methods.

Keywords: benchmark, dynamics, PID tuning, model predictive control, microcontroller

*corresponding author

Email address: john_hedengren@byu.edu (John D. Hedengren)

1. Introduction

Benchmark problems are standard repositories in many scientific disciplines such as systems biology [1, 2], reservoir modeling [3, 4, 5, 6], drilling [7, 8], optimization [9, 10], dynamic optimization [11, 12], singular optimal control [13, 14], combined scheduling and control [15, 16, 17, 18], and others [19, 20, 21]. The benchmark problems serve as a consistent measure of innovations that are proposed to increase profitability or improve some aspect of control or optimization performance.

There are many standard benchmark models for testing the performance of estimation and control methods in chemical process control. Some of these include a continuously stirred tank reactor (CSTR) with a single exothermic reaction [22, 23, 24]. One of the most commonly cited models in chemical process control is the Tennessee Eastman Process [25, 26]. The Tennessee Eastman Process encapsulates valve characteristics, measurement noise, process nonlinearity, and complex interactions between processing units for chemical manufacture.

Besides simulation, there are standard hardware benchmarks for evaluating control performance such as UAV control [27], process control education modules [28, 29], and quadruple tank level control [30, 31, 32]. There are also many studies where the authors build a unique test system or implement control on an industrial process [33, 34] and demonstrate various control methods. However, hardware benchmarks may be difficult to reproduce or the industrial process may be unavailable for independent researchers to also obtain data or test methods in closed-loop.

The purpose of this paper is to demonstrate a standard hardware benchmark for control methods with a micro-controller temperature control device. This Temperature Control Lab (TCLab) is used as an education module for courses in process dynamics and control [35, 36]. As many have noted in assessments of process control education, there is a need to give students realistic and hands-on experiences with process control [37, 38, 39]. Industry desires foundational and practical knowledge of control engineering concepts that are reinforced with

31 physical modules. Because the TCLab, as an educational module, has wide dis-
 32 tribution to universities and industrial practitioners (3000 units), it has potential
 33 as a standard hardware benchmark for control engineering studies. Section 2
 34 gives details of the device to enable replication of the TCLab.

35 2. Temperature Control Lab Device

36 The TCLab is printed circuit board (PCB) shield that connects to an Ar-
 37 duino micro-controller. The TCLab shield has two transistors as heaters and
 38 two thermistor temperature sensors as shown in Figure 1. A step response of
 39 the heater (0-100%) has a temperature response with an approximate dominant
 40 time constant (τ) of 2.9 min and a gain of $0.9 \frac{^{\circ}\text{C}}{\% \text{heater}}$. The process exhibits
 41 second order dynamics and the two adjacent heaters create a compact multi-
 42 variate control system. The Arduino micro-controller is an Arduino Uno or
 43 Arduino Leonardo that includes a 10-bit Analog to Digital Converter (ADC) to
 44 measure voltage of the temperature sensors in 1024 (2^{10}) discrete analog levels
 45 and Pulse Width Modulation (PWM) with 256 (2^8) levels to change the output
 46 to the heaters and LED.

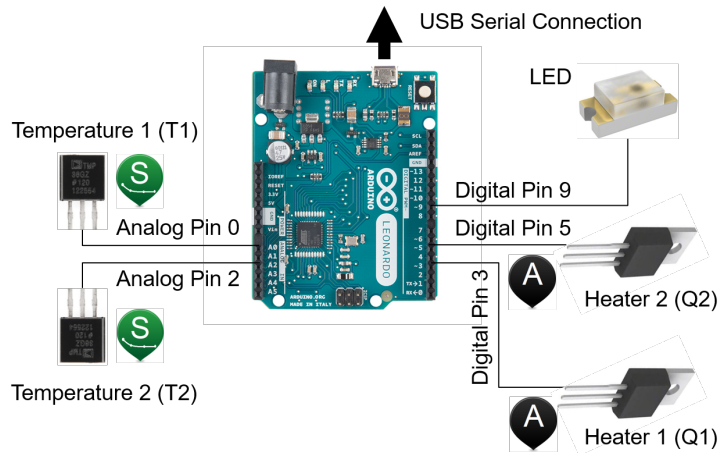


Figure 1: Temperature sensors and heater transistors with connections to an Arduino Leonardo.

47 The transistor heaters are TIP31C NPN Bipolar Junction Transistors (BJTs)
48 in a TO-220 package. These transistors are commonly used in audio, power, and
49 switching applications but not commonly as heaters. During the development
50 of the TCLab, the initial design was to include a MOSFET transistor (low
51 power loss switch) with a power resistor as the heating element. Instead, the
52 BJT TIP31C is able to act as both the switch and the heater, thereby simpli-
53 fying the design and reducing the cost of the hardware. The two temperature
54 sensors on the TCLab are standard TMP36GZ thermistors with an output volt-
55 age (mV) that is linearly proportional to temperature ($T^{\circ}C = 0.1 mV - 50$)
56 and no requirement for calibration. Typical sensor accuracy is $\pm 1^{\circ}C$ at room
57 temperature ($25^{\circ}C$) and $\pm 2^{\circ}C$ over the $-40^{\circ}C$ to $150^{\circ}C$ operating range.

58 As a safety and equipment protection precaution, the Arduino micro-controllers
59 come pre-programmed to shut off the heaters if the temperature rises above
60 $100^{\circ}C$. The heaters are powered by a 5V 2A power supply for a maximum
61 power output of 10 W. A 20 AWG (American Wire Gauge) power cable reduces
62 the power dissipation compared to standard 24 AWG power cables with a barrel
63 jack connector. A USB cable connects the Arduino to a computer for serial data
64 communication. One TIP31C heater and one TMP36GZ sensor are connected
65 to each other and with a thermal heat sink attached to the TIP31C transistor.
66 The two heater units are placed in proximity to each other to transfer heat by
67 convection and thermal radiation.

68 Software interfaces to TCLab in Python, MATLAB, and Simulink are de-
69 scribed in Appendix A. The software adjusts the two heater levels between 0
70 and 100% and the LED brightness between 0 and 100% using PWM with 2^8
71 discrete levels. The PWM rapidly fluctuates between on and off to give nearly
72 continuous values 0, 0.392, 0.784, . . . , 99.61, 100 for actuation of the heaters and
73 LED.

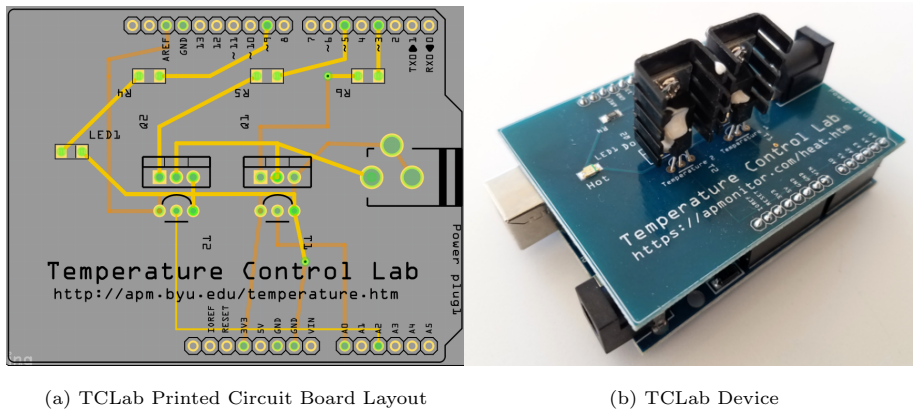


Figure 2: Temperature Control Lab Design

74 3. Temperature Response Models

75 This section summarizes four simulation models that describe the dynamic
 76 response of the heaters to temperature changes. The four are a lumped param-
 77 eter energy balance (Section 3.1), a first-order plus dead-time (FOPDT) model
 78 (Section 3.2), a higher-order autoregressive exogenous input (ARX) model (Sec-
 79 tion 3.3), and an artificial neural network (ANN) steady state and linear dy-
 80 namic Hammerstein model (Section 3.4). Section 3.5 compares all of the models
 81 on open-loop step test data both for Single Input Single Output (SISO) and Mul-
 82 tiple Input Multiple Output (MIMO) modes. Multivariate, model-based control
 83 relies on an accurate simulation of the process. The models described in this
 84 section are not an exhaustive list of physics-based and empirical representations.
 85 Each TCLab device is slightly different so the model parameters are uniquely
 86 identified. One of the principal differences is the ambient temperature where
 87 the test occurs. Other potential disturbances include the power supply output,
 88 air currents (e.g. nearby computer fan), and others. Figure 3 shows variability
 89 due to ambient temperature differences for six tests that use the same heater
 90 profile. With $\pm 2.5^\circ C$ ambient temperature difference, there is a similiar spread
 91 in the heater temperature response although the trends are not parallel and
 92 completely predictable, especially for heater 2 temperature.

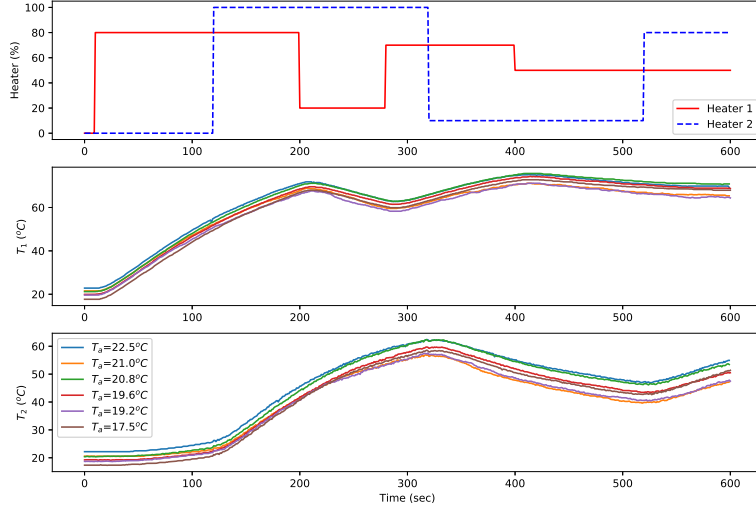


Figure 3: Variations in ambient temperature influence the temperature profiles

93 Along with measurement noise, the stochastic nature of the data is a feature
 94 of the lab that portrays performance on a physical system. Reporting, plotting,
 95 or controlling the starting (ambient) temperature is an important requirement
 96 of the benchmark as shown in Figure 4.

97 According to the slope of the regression, an ambient temperature increase of
 98 $1^{\circ}C$ equates to a $0.928 \pm 0.033^{\circ}C$ rise in average temperature of the step tests.
 99 One possible explanation for the slope less than unity is the radiative heat
 100 transfer that has a quadratic dependence on absolute temperature and would
 101 lose heat at a higher rate at elevated conditions. The main conclusion from this
 102 result is that ambient temperature has a reproducible effect on the outcome of
 103 benchmark tests and should be reported and controlled for repeatable results.

104 3.1. Physics-based Model

105 A lumped parameter model with convection, conduction, and thermal radi-
 106 ation describes the second-order temperature response to heater changes. The
 107 lumped parameter model is a simplification of a more rigorous finite element

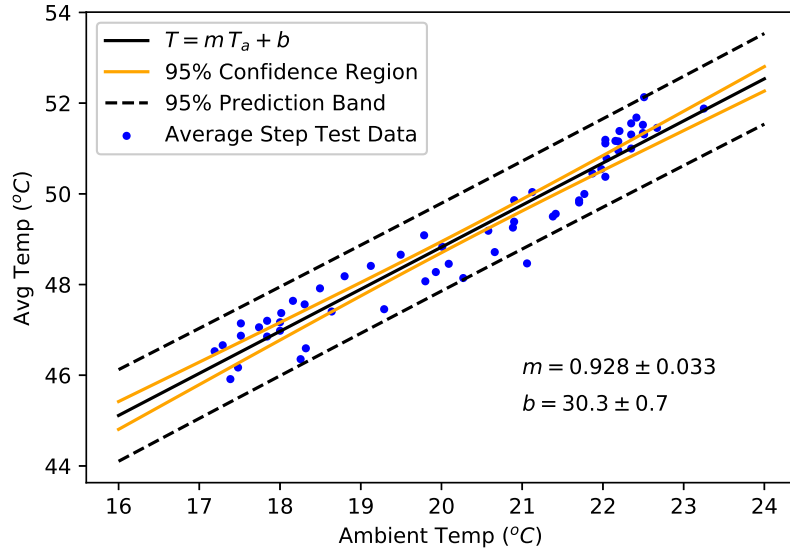


Figure 4: Correlation of ambient temperature to average temperature during 60 step tests (10 min each)

108 analysis (FEA) that tracks the temperature distribution throughout the heat
 109 sink and loss to the environment as shown in Figure 5.

110 Details of the FEA simulation are not provided here but do provide a confir-
 111 mation that the temperature distribution is sufficiently uniform ($< 3^\circ C$) for a
 112 lumped parameter assumption. The lumped parameter model assumes that the
 113 heaters (T_{H1} and T_{H2}) and temperature sensors (T_{C1} and T_{C2}) have a uniform
 114 temperature. The temperature sensors (T_{C1} and T_{C2}) have a small thermal
 115 mass and surface area and temperature changes are driven by heat conduction
 116 from the heaters (T_{H1} and T_{H2}) where they are attached with thermal epoxy.
 117 Parameters of the lumped parameter model are given in Table 1.

118 The dynamic input power to each transistor and the temperature sensed
 119 by each thermistor is developed with energy balance equations (Equations 1-4)
 120 that account for convection, conduction, and thermal radiation. The amount
 121 of convective heat transfer from heater 1 to heater 2 is given by $Q_{C12} =$

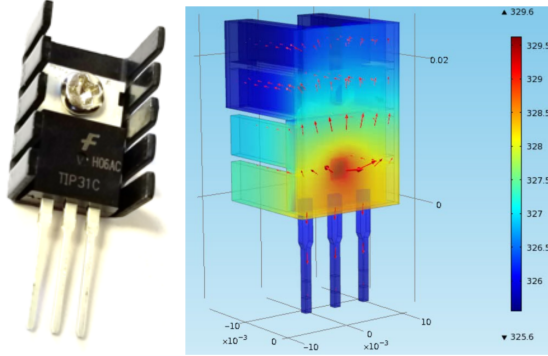


Figure 5: Finite Element Analysis of the Dynamic Temperature Response.

Table 1: Lumped Parameters from Physics-based Model

Quantity	Value
Initial temperature (T_0)	296.15 K (23°C)
Ambient temperature (T_∞)	296.15 K (23°C)
Heater output (Q_1)	0 to 1 W
Heater factor (α_1)	0.0131-0.0132 W/(% heater)
Heater output (Q_2)	0 to 0.75 W
Heater factor (α_2)	0.0063-0.0066 W/(% heater)
Heat capacity (C_p)	500 J/kg-K
Surface Area Not Between Heaters (A)	$1.0 \times 10^{-3} \text{ m}^2$ (10 cm^2)
Surface Area Between Heaters (A_s)	$2 \times 10^{-4} \text{ m}^2$ (2 cm^2)
Mass (m)	0.004 kg (4 gm)
Heat Transfer Coefficient (U)	4.4-4.6 $\text{W}/\text{m}^2 - \text{K}$
Heat Transfer Coefficient Between Heaters (U_s)	23.6-24.4 $\text{W}/\text{m}^2 - \text{K}$
Emissivity (ϵ)	0.9
Stefan Boltzmann Constant (σ)	$5.67 \times 10^{-8} \text{ W}/\text{m}^2 - \text{K}^4$
Conduction Time Constant (τ_c)	21.1 – 23.3 sec

¹²² $U_s A_s (T_{H2} - T_{H1})$. The radiative heat transfer from heater 1 to heater 2 (or

123 vice versa) is given by $Q_{R12} = \epsilon \sigma A (T_{H2}^4 - T_{H1}^4)$.

$$m c_p \frac{dT_{H1}}{dt} = U A (T_\infty - T_{H1}) + \epsilon \sigma A (T_\infty^4 - T_{H1}^4) + Q_{C12} + Q_{R12} + \alpha_1 Q_1 \quad (1)$$

$$m c_p \frac{dT_{H2}}{dt} = U A (T_\infty - T_{H2}) + \epsilon \sigma A (T_\infty^4 - T_{H2}^4) - Q_{C12} - Q_{R12} + \alpha_2 Q_2 \quad (2)$$

124 The dynamic temperature response of the two temperature sensors are pri-
 125 marily by conductive heat transfer from the heaters. The temperature sensors
 126 are small in mass and surface area relative to the heaters so the heat transfer by
 127 other mechanisms is ignored. The time constant τ_c is a lumped parameter from
 128 a discretized version of Fick's Law of heat transfer with $\tau_c = m_s c_{ps} \Delta x / k_c A_{cond}$,
 129 where m_s is the mass of the sensor, c_{ps} is the heat capacity of the sensor, k_c is
 130 the thermal conductivity of the thermal epoxy, and Δx is the width of the ther-
 131 mal epoxy. These parameters are combined together into one parameter τ_c and
 132 estimated from the data. The dynamic sensor temperature response expressions
 133 are Equations 3 and 4.

$$\tau_c \frac{dT_{C1}}{dt} = T_{H1} - T_{C1} \quad (3)$$

$$\tau_c \frac{dT_{C2}}{dt} = T_{H2} - T_{C2} \quad (4)$$

134 The test of the physics-based model is performed in two phases that includes
 135 a model fitting phase followed by validation. The model fitting adjusts the pa-
 136 rameters U , U_s , α_1 , α_2 , and τ_c to minimize the sum of squared error between
 137 the model prediction and data as shown in Figure 6a. The model validation is a
 138 simulation of the temperature profile given a different heater profile. The mea-
 139 sured temperatures are not used in performing the simulation but are compared
 140 afterwards to determine how well the model fitting performs on independent
 141 data as shown in Figure 6b.

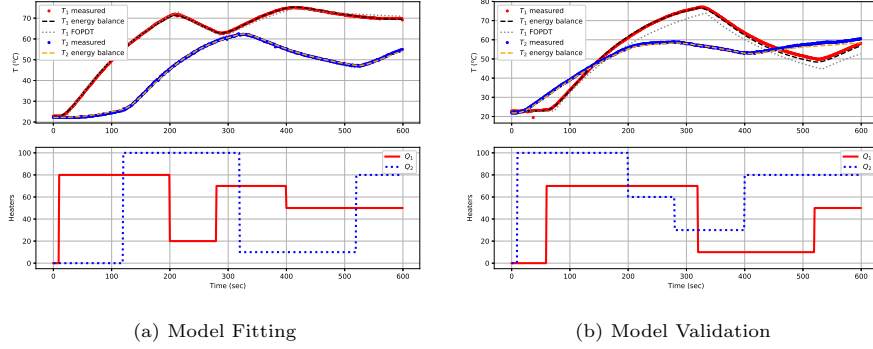


Figure 6: Dual Heater Step Response of the TClab with Physics-based and FOPDT Model

142 3.2. First-Order Plus Dead-time Model

143 In addition to the physics-based model, a first-order plus dead-time (FOPDT)
 144 model is fit to step response data. An FOPDT model includes the gain ($K_p=0.92$
 145 $^{\circ}\text{C}/\%$), time constant ($\tau_p=175.2 \text{ sec}$), and delay time ($\theta_p=15.6 \text{ sec}$). The FOPDT
 146 model is a single differential equation as shown in Equation 5.

$$147 \tau_p \frac{dT_{C1}}{dt} = -T_{C1} + K_p Q_1 (t - \theta_p) \quad (5)$$

148 The discrete solution to the FOPDT equation is Equation 6 when there is
 149 a zero-order hold for the heaters between sampling intervals (Δt) between time
 interval j and $j - 1$.

$$150 T_{C1,j} = e^{-\frac{\Delta t}{\tau_p}} (T_{C1,j-1} - T_{C1,0}) + \left(1 - e^{-\frac{\Delta t}{\tau_p}}\right) K_p (Q_{1,j-\theta_p-1} - Q_{1,0}) + T_{C1,0} \quad (6)$$

151 The FOPDT model is used in this example for obtaining initial tuning pa-
 152 rameters to a Proportional-Integral-Derivative (PID) controller for an optimization-
 153 based tuning approach as detailed in Section 4. Heater 1 (Q_1) is adjusted with
 154 variable step sizes and heater 2 (Q_2) remains off to generate step response data
 155 for the FOPDT. The results of the temperature data and model fit is shown in
 Figure 7a and Figure 7b for validation with a different heater profile.

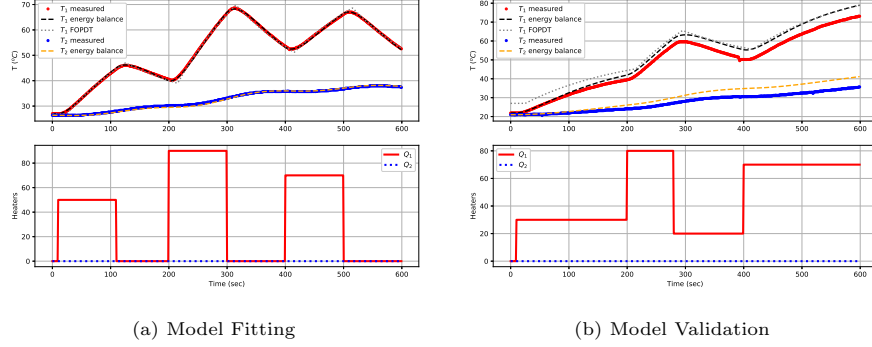


Figure 7: Single Heater Step Response of the TCLab with Physics-based and FOPDT Model

156 The physics-based model has a lower average absolute error while the FOPDT
 157 model has a higher error because a first order model is fit to a higher order re-
 158 sponse. The physics-based model fits the temperature response better when the
 159 heater is adjusted because of the second-order model and nonlinear radiative
 160 heat transfer term.

161 3.3. Linear Time Series Models

162 Auto-Regressive eXogenous input (ARX) time series models are a linear
 163 representation of a dynamic system in discrete time. The ARX, Output Error
 164 (OE), Finite Impulse Response (FIR), State Space (SS), and other forms are
 165 common in industrial multivariate identification and control [40]. Equation 7
 166 is an ARX time series model with a single heater input and single temperature
 167 output with k index for the time step, i index for prediction horizon step, and
 168 adjustable parameters α , β , and γ .

$$T_{C1,k+1} = \sum_{i=1}^{n_\alpha} \alpha_i T_{C1,k-i+1} + \sum_{i=1}^{n_\beta} \beta_i Q_{1,k-i+1} + \gamma \quad (7)$$

169 With $n_\alpha = 3$ and $n_\beta = 2$ the time series model has 5 adjustable parameters
 170 and is shown in Equation 8. The ARX form uses prior temperature measure-
 171 ments to predict the next temperature in the series, $T_{C1,k+1}$, while the OE

172 form uses prior temperature predictions to predict the next temperature in the
 173 sequence. The γ_1 value is adjusted to create an unbiased model prediction.

$$T_{C1,k+1} = \alpha_1 T_{C1,k} + \alpha_2 T_{C1,k-1} + \alpha_3 T_{C1,k-2} + \beta_1 Q_{1,k} + \beta_2 Q_{1,k-1} + \gamma_1 \quad (8)$$

174 The OE identification form is used to reduce model bias. Equations 9a and
 175 9b have multiple inputs and multiple outputs for the case when $n_\alpha = 2$ and
 176 $n_\beta = 1$.

$$T_{C1,k+1} = \alpha_{1,1} T_{C1,k} + \alpha_{2,1} T_{C1,k-1} + \beta_{1,1} Q_{1,k} + \beta_{1,2} Q_{2,k} + \gamma_1 \quad (9a)$$

177

$$T_{C2,k+1} = \alpha_{1,2} T_{C2,k} + \alpha_{2,2} T_{C2,k-1} + \beta_{2,1} Q_{1,k} + \beta_{2,2} Q_{2,k} + \gamma_2 \quad (9b)$$

178 An advantage of a linear time invariant (LTI) model such as SS, ARX, FIR,
 179 or OE is that little or no physics-based information is required to obtain a
 180 model prediction. When constraints are available, they are used to improve the
 181 identification [41]. The model fit to the step test data is shown in Figure 8a and
 182 the validation in Figure 8b.

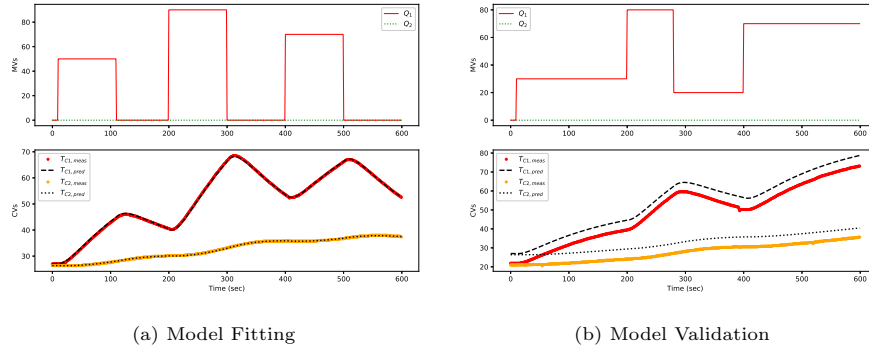


Figure 8: Single Heater Step Response of the TCLab with Linear Time Series

183 There is insufficient data information to determine the β values associated
 184 with Q_2 because the value stays at zero for the duration of the test. A second

185 test is conducted where the second heater is also adjusted to get a multivariate
 186 model from the step response data (see Figure 9).

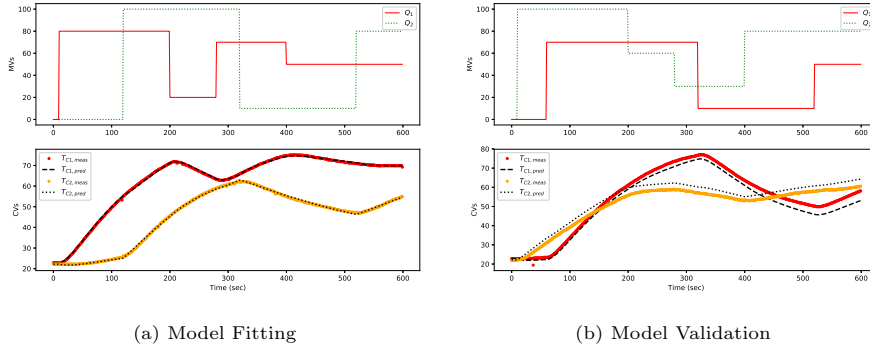


Figure 9: Dual Heater Step Response of the TCLab with Linear Time Series

187 *3.4. Hammerstein Model with Artificial Neural Network*

188 A final modeling approach is a Hammerstein Model with an Artificial Neural
 189 Network (ANN) to predict the steady-state relationship between the heaters
 190 and temperatures and a linear dynamic block that translates the steady-state
 191 prediction into a dynamic prediction. The ANN is not trained directly on the
 192 dynamic data because a Recurrent Neural Network or Convolutional Neural
 193 Network is better suited for this type of predictive model and this is the topic
 194 of future work. A diagram of the model is shown in Figure 10.

195 The parameter weights, represented by arrows connecting each of the nodes,
 196 are adjusted to minimize a sum of squared error with 70 steady-state data points.
 197 The steady-state data points are obtained by setting random heater values be-
 198 tween 0 and 80% for 5 min, recording the temperatures, and then adjusting the
 199 heater values to random levels for another data point. Although the system
 200 does not fully reach steady-state (2τ or 95% of change), it is judged to be
 201 sufficiently close to fit the steady-state correlation. The linear dynamic part is
 202 approximated as a second-order dynamic relationship between the steady-state
 203 temperature outputs of the ANN and the dynamic response with $\tau_{p1}=140\text{ sec}$

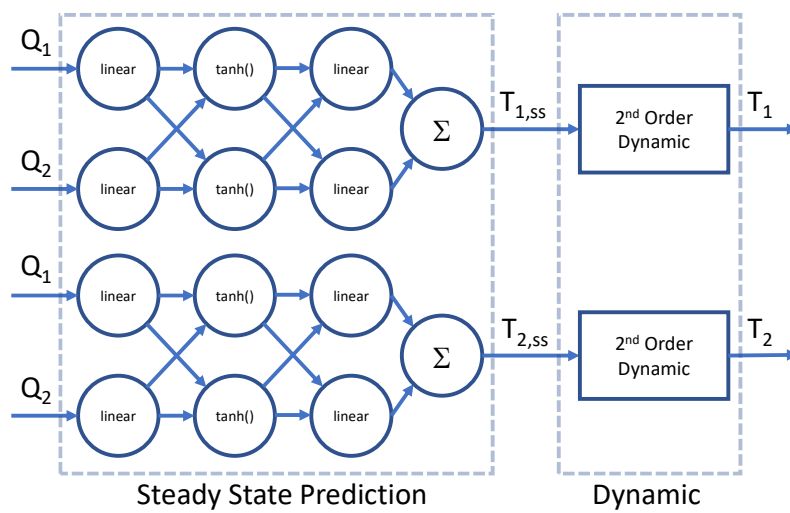


Figure 10: Architecture of the Hammerstein Model with a Steady-State Artificial Neural Network and Linear Dynamics.

204 and $\tau_{p2}=20$ sec. The second order system approximates the time constant for
 205 the heater and temperature sensor with heat conduction between the two.

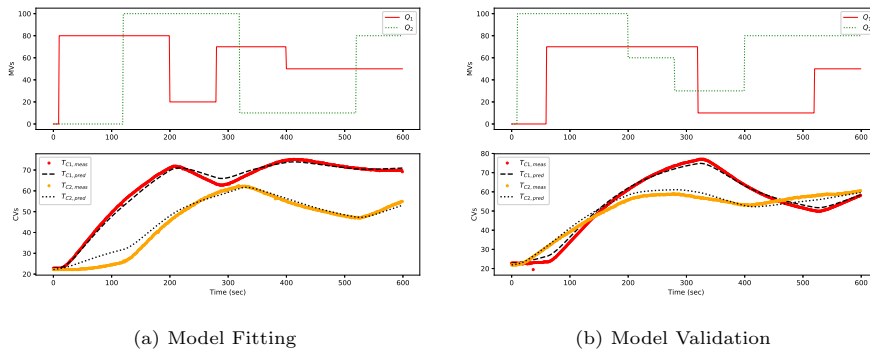


Figure 11: Hammerstein Model Fitting and Validation with 2 Heaters

206 The fitting data is shown in Figure 11a and validation is shown in Figure 11b.
 207 Because the steady-state data is a different data set than the dynamic fitting
 208 data set, there is some offset between the predictions and data. There are many
 209 ANN forms and a future case study could investigate the use of convolutional
 210 or recurrent neural networks such as a network with LSTM (Long Short-Term
 211 Memory) nodes to combine the dynamic and steady-state predictions into one
 212 model.

213 3.5. Summary of Model Predictions with Validation

214 For model-based controllers, the choice of model depends on many factors
 215 such as computation speed, ability to extrapolate outside the training region,
 216 degree of nonlinearity, and others. Table 2 summarizes the model fit to data
 217 with the model regression and validation tests as an average sum of absolute
 218 error.

219 4. Benchmarking Closed-Loop PID Re-Tuning

220 The PID controller is a widely used basic regulatory control algorithm. PID
 221 control is important in chemical engineering processes as it plays a critical role

Table 2: Summary of Regression and Validation for Single Heater (SISO) and Dual Heater (MIMO) Tests

	Model Description	Training	Validation
SISO	Physics-based Lumped Parameter	0.20 °C	3.32 °C
SISO	First-order Plus Dead-time	0.41 °C	5.11 °C
SISO	Second Order ARX	0.18 °C	5.16 °C
SISO	Hammerstein with ANN and Linear Dynamics	3.83 °C	1.66 °C
MIMO	Physics-based Lumped Parameter	0.23 °C	0.70 °C
MIMO	Second Order ARX	0.26 °C	2.66 °C
MIMO	Hammerstein with ANN and Linear Dynamics	1.57 °C	1.55 °C

222 as a base regulatory layer foundation for advanced process control and opti-
 223 mization systems. PID performance varies greatly on the parameters obtained
 224 from tuning rules or heuristics [42, 43]. Control performance metrics such as
 225 minimum variance control are common assessments of performance [44, 45].
 226 Methods such as Zeigler-Nichols closed-loop tuning requires sustained oscilla-
 227 tion data to obtain an ultimate gain (K_u) and ultimate period (P_u) [46]. To
 228 avoid driving a process to the limitation of the stability region to obtain the
 229 sustained oscillation data, a relay method is introduced [47]. Tuning rules are
 230 a valuable starting point for further manual tuning but may not be optimized.
 231 Optimization-based PID tuning is another option with prior work in extremum
 232 seeking [48] algorithms, particle swarm [49, 50], and meta-heuristics such as
 233 genetic algorithms [51].

234 The objective of this closed-loop PID re-tuning is to demonstrate a TCLab
 235 benchmark that uses historical data to optimally re-tune a PID controller. An
 236 exhaustive search method visits all feasible combinations of the PI or PID pa-

237 rameters to find an optimal value of the objective function without converging to
 238 a local minimum for both output-error and input-move deviations. The method
 239 uses simulation of the physical TCLab PID controller by: (a) re-playing back
 240 the past or historical setpoint and load disturbances [52]; (b) allowing multi-
 241 ple, simultaneous and probability-weighted process models to be included in
 242 the simulations (i.e., multiple scenarios or situations each with specified proba-
 243 bilities) for robustness; (c) including multiple and simultaneous PID controller
 244 configuration formulations or even *ad hoc* controller designs; (d) specifying any
 245 type of performance objective function criteria i.e., simultaneously minimize the
 246 output-error and input-move variances, overshoot, etc. (e) adding stability rules
 247 in the search to cut-off unstable sections of the closed-loop operating space and
 248 (f) utilizing an indirect and constrained controller design technique [53].

249 The exhaustive search method is tested with the TCLab as a benchmark for
 250 closed-loop control performance. The TCLab produces the closed-loop operat-
 251 ing data with IMC PID parameters and a selected setpoint change sequence. A
 252 deterministic parametric process model is then identified using an ARX struc-
 253 tured model using the GEKKO dynamic optimization suite [54], estimating
 254 coefficients using a least-squares prediction-error objective function. Then, the
 255 exhaustive search method evaluates the range or domain of the different P , I ,
 256 and/or D parameters. The best search objective function found provides the P ,
 257 I , and/or D . The PID controller is then run again with the temperature control
 258 lab using the re-tuned PID parameters and the data recorded. There are many
 259 derivations of PID formula rooted in the original continuous equation [42]. For
 260 implementing PID controllers in modern digital control platforms such as a DCS
 261 (Distributed Control Systems) or PLC (Programmable Logic Controllers), two
 262 popular discrete forms are widely used in industry. One is the positional form
 263 (Equation 10a) and the other is the velocity form (Equation 10b), which are
 264 exchangeable.

$$OP_t = OP_{bias} + K_c \left(e_t + \frac{\Delta t}{\tau_I} \sum_1^t e_t + \tau_D \frac{PV_{t-1} - PV_t}{\Delta t} \right) \quad (10a)$$

$$OP_t = OP_{t-1} + K_c \left((e_t - e_{t-1}) + \frac{\Delta t}{\tau_I} e_t + \frac{\tau_D}{\Delta t} (PV_t - 2PV_{t-1} + PV_{t-2}) \right) \quad (10b)$$

266 where the output error $e_t = SP_t - PV_t$. Whereas the positional form calculates
 267 the controller output position (OP), the velocity form calculates the change in
 268 controller output ($\Delta OP = OP_t - OP_{t-1}$). Although the positional form is more
 269 straightforward to understand as the P , I , and D terms are directly translated
 270 from the original continuous form, the velocity form has several advantages from
 271 the convenience perspective such as no additional logic is required for anti-reset
 272 windup [55]. The positional form PI controller is used in this study while a prior
 273 study [53] used a PID controller in velocity form. In both cases, an ARX model
 274 is identified from closed-loop data. ARX and Box-Jenkins models have proven
 275 consistency in closed-loop identification [56, 57]. The potential PID tunings are
 276 re-played with the same past setpoint and load disturbance as in the process
 277 data (y_t) with $z_t = y_t - x_t$ where, x_t represents the ARX model output for
 278 time-step t . The load disturbance (z_t) is super-imposed on the ARX simulated
 279 process output during the search for optimal tuning parameters.

280 Two different types of objective functions are considered for PID tuning. The
 281 objective functions are a variation of the PID control performance index known
 282 as average IAE (Integral Absolute Error). The objective function consists of the
 283 output-error (OE) term, and the input movement (IM) term. The optimization
 284 solution of output error combined with input movement (or, rate of change)
 285 has been analytically derived and investigated in [58] and is the simplest form
 286 of move suppression. These multi-objective functions can be express in two
 287 different ways. One is Archimedean and the other is the lexicographic form (or
 288 goal programming) as shown in Equations 11 and 12, respectively.

$$\min_{K_c, \tau_I, \tau_D} J = \frac{\sum_{i=1}^t (w_{OE} \|SP_i - x_i\|_n + w_{IM} \|OP_i - OP_{i-1}\|_n)}{t} \quad (11)$$

289 where n is the norm w is the weighting factor for each term in the objective

290 function denoted as *OE* for output error and *IM* for input movement.

$$\min_{K_c, \tau_I, \tau_D} J = \frac{\sum_{i=1}^t (\|SP_i - x_i\|_n)}{t} \text{ Subject to } \|OP_i - OP_{i-1}\|_n \leq UB_{IM} \quad (12)$$

291 where *UB* is the upper bound of the input movement (*IM*) which may be
 292 initially set by the centroid PID performance. Either the Archimedean or lexi-
 293 cographic form of the objective function can be used for PID controller tuning.
 294 In terms of convenience, the lexicographic form is easier to use because it re-
 295 quires one user input parameter, UB_{IM} , as opposed to the Archimedean form
 296 that requires two weighting factors on both OE and IM terms. One simplifi-
 297 cation of the Archimedean form is to reduce the weighting factors to one by
 298 dividing the objective by w_{OE} .

299 4.1. TCLab Benchmark Validation

300 The first step of the validation is to collect the closed-loop operation data
 301 and identify the ARX model parameters for identifying the ARX model. The
 302 setpoint is changed from ambient temperature at the initial steady-state con-
 303 dition to 50 °C, 40 °C, and then to 60 °C. The ranges of K_c and τ_I are
 304 evaluated through the ARX model that includes the same setpoint sequences
 305 and load disturbance. The performance objective functions for each K_c and τ_I
 306 incremental combination are also calculated and stored. The ℓ_1 -norm objective
 307 function in the Archimedean form is chosen for the test with weighting factors
 308 $w_{OE} = 1$ and $w_{IM} = 0.5$. The K_c and τ_I combination that gives a minimum
 309 value of objective function is then chosen as optimal PID tuning. The initial K_c
 310 and τ_I are from the FOPDT model in Section 3.2 and IMC aggressive tuning
 311 with $K_c = 5.74 \frac{\%}{\circ C}$ and $\tau_I = 175.2 \text{ sec}$. Optimized values are $K_c = 10.0 \frac{\%}{\circ C}$ and
 312 $\tau_I = 55.0 \text{ sec}$ as shown as the minimum value of the objective function contour
 313 map (see Figure 12).

314 The objective function surface is not smooth because of the load disturbances
 315 that are replayed with every PID parameter combination. Figure 13 shows
 316 the measured temperature and ARX model response for both the original and

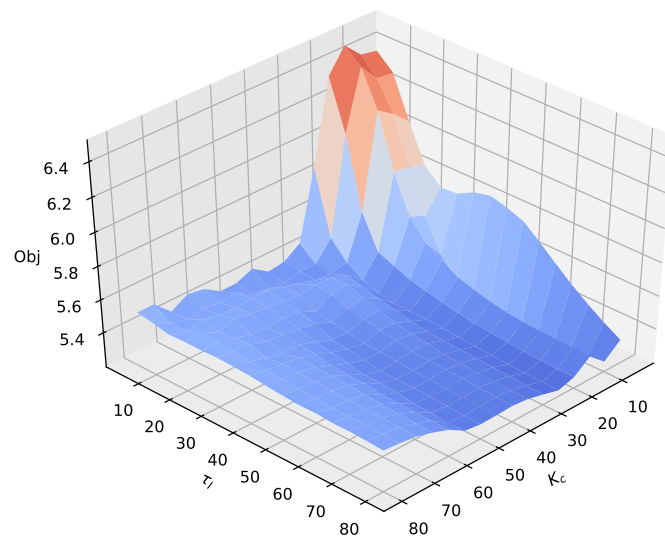


Figure 12: Average Integral Absolute Error (IAE) with K_c and τ_I PID Parameters.

317 optimized response. The validation of the optimal tuning parameter is displayed
 318 as well.

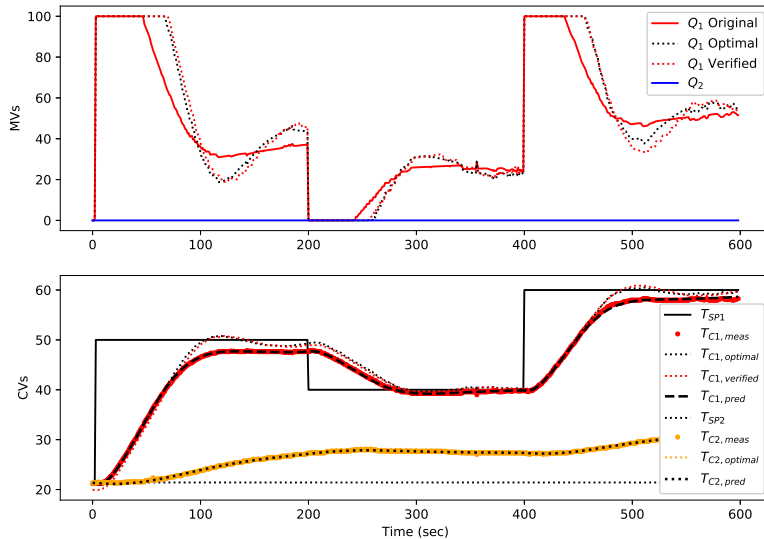


Figure 13: ARX Simulated and TCLab Validated Performance Improvement of 5.4%.

319 The average IAE objective function is 6.09 with IMC tuning and 5.76 with
 320 optimized parameters, an improvement of 5.4%. The PID improvement is simu-
 321 lated with the ARX model and validated with closed-loop data from the Arduino
 322 TCLab.

323 5. Multivariate Control Benchmark

324 Model predictive control (MPC) with the physics-based model, time series
 325 linear model (ARX), and Hammerstein ANN model quantify multivariate control
 326 performance. Additional models in MPC or multivariate control strategies
 327 are tested with the TCLab. This section shows benchmark performance with
 328 three popular methods for multivariate control that range from linear to non-
 329 linear and empirical to physics-based.

330 An ℓ_1 -norm objective function gives a target region for the temperature
 331 range, rather than one specific target value. Equation 13 shows the ℓ_1 -norm
 332 control formulation used in this work for model predictive control (MPC).

$$\begin{aligned}
 \min_{x, CV, MV} J &= w_{hi}^T e_{hi} + w_{lo}^T e_{lo} + \Delta Q^T c_{\Delta Q} \\
 \text{s.t.} \quad 0 &= f\left(\frac{dT}{dt}, T, Q\right) \\
 e_{hi} &\geq T - T_{hi} \\
 e_{lo} &\geq T_{lo} - T
 \end{aligned} \tag{13}$$

333 where J is the objective function, T is the temperature, Q is the heater, w_{lo}
 334 and w_{hi} are penalty matrices for solutions outside the target temperature region.
 335 Slack variables e_{lo} and e_{hi} are the error of the dead-band low and high limits,
 336 respectively. Parameter $c_{\Delta Q}$ is a move suppression factor. The function f is an
 337 open-equation set of model equations that include T , Q , and time derivatives
 338 of T . The demand targets T_{lo} and T_{hi} define lower and upper target limits for
 339 temperature as shown in Figure 14.

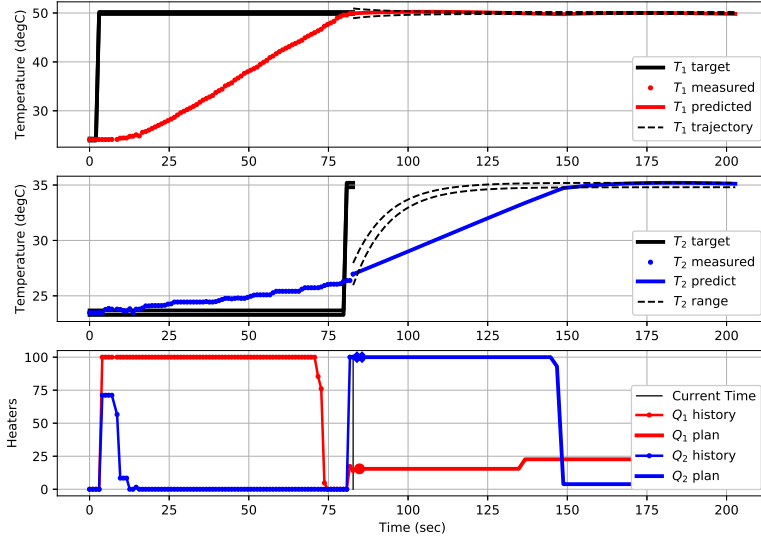


Figure 14: MPC with ARX Model at Cycle 81

340 At cycle 81, temperature 1 has just reached the target temperature setpoint
 341 of 50 °C after heater 1 is ramped down from 100% to 0% at 10-15 sec prior to
 342 reaching the setpoint. The model predictive controller anticipates the continued
 343 rise in temperature and turns the heater off for a period of 5 seconds before
 344 returning to a baseline heater value to maintain the 50 °C setpoint. The model
 345 also anticipates the increase in temperature 2 due to the setpoint change to 35
 346 °C at cycle 80. The reference trajectory with time constant $\tau=10$ sec gives a
 347 guide for the fastest that the temperature should approach the new setpoint.
 348 The setpoint has a ± 0.2 °C range with a ± 1.0 °C larger opening at the beginning
 349 for less MV movement for near-term adjustments. The underlying ARX time-
 350 series model coordinates the MV movements to meet both setpoints considering
 351 multivariate effects.

352 6. Benchmarking Model Predictive Control

353 The multivariate models developed in Sections 3.1, 3.3, and 3.4 are compared
 354 in MPC. The MPC uses an ℓ_1 -norm objective with a temperature dead-band of
 355 ± 0.2 °C for $T_{hi} - T_{sp}$, $T_{lo} - T_{sp}$ and a first-order reference trajectory of 10 sec
 356 for setpoint changes. The move suppression factor $c_{\Delta Q}$ is set to 0.1, the weights
 357 w_{hi} and w_{lo} are set to 20.0, and the control and prediction horizon are 60 sec-
 358 onds. The linear ARX model has a cycle time of 1 second while the nonlinear
 359 physics-based and Hammerstein applications are re-computed every 2 seconds.
 360 The longer cycle time is required to enable all steps of data retrieval, model
 361 update, re-calculation of optimal move plan, retrieval of first step, and insertion
 362 into the process. Table 3 is a numeric comparison of the methods with quan-
 363 tified IAE rate (°C/sec) and Integral Average Move rate (%/sec) for the heater
 364 adjustments. Another common performance metric is a minimum variance as
 365 applied to multivariate control systems [59, 60]. Rate-based values are shown
 366 in this case because of the differing cycle times between the applications.

367 The benchmark results show that all models perform equally well in terms
 368 of the control performance (11.4-11.6 °C/sec) as shown in Figures 15 to 17.

Table 3: Summary of Model Predictive Control Methods

Model Description		IAE Avg Rate (CVs)	IAE Avg Rate (ΔMVs)
Physics-based	Lumped	11.5 $^{\circ}C/sec$	2.0 $\%/sec$
Parameter			
Second Order ARX		11.6 $^{\circ}C/sec$	3.3 $\%/sec$
Hammerstein with ANN and Linear Dynamics		11.4 $^{\circ}C/sec$	2.5 $\%/sec$

369 In all cases, T_1 is not able to reach the setpoint of $30^{\circ}C$ between 160-320 sec
370 because of insufficient cooling rate when Q_1 is off. The ARX model has the
371 highest MV movement (3.3 $\%/sec$) and the physics-based model has the lowest
372 MV movement even with rapid fluctuations on Q_2 during the first setpoint
373 change at $t = 105$ sec. The values for MPC are more than the PID control
374 performance metric because there are two CVs and two MVs that accumulate
375 error approximately twice as fast and with more frequent setpoint changes.

376 The physics-based model has the potential to extrapolate to new operating
377 conditions without retuning. A physics-based MPC has the disadvantage of
378 relative difficulty in developing the model equations for complex systems. There
379 is also a potential for solver convergence problems if the physics-based model
380 is high nonlinear or does not have a suitable initial guess. This is not the case
381 for the TCLab where an approximate lumped-parameter model is an accurate
382 representation of the physical system. One drawback for the physics-based MPC
383 is that it cannot run at 1 sec cycles but does solve within a 2 second interval for
384 a 60 sec prediction horizon. The ARX control performance is shown in Figure
385 16.

386 The ARX MPC has the fastest cycle time (1 sec versus 2 sec) so that it can
387 respond more quickly to disturbances or setpoint changes. Because it is a linear
388 model, the cycle time can be faster (up to 5 Hz) due to reduced computing time.
389 The disadvantage of the ARX MPC is that it is a linear representation of the
390 slightly nonlinear TCLab. This requires re-adjustment of the move plan and

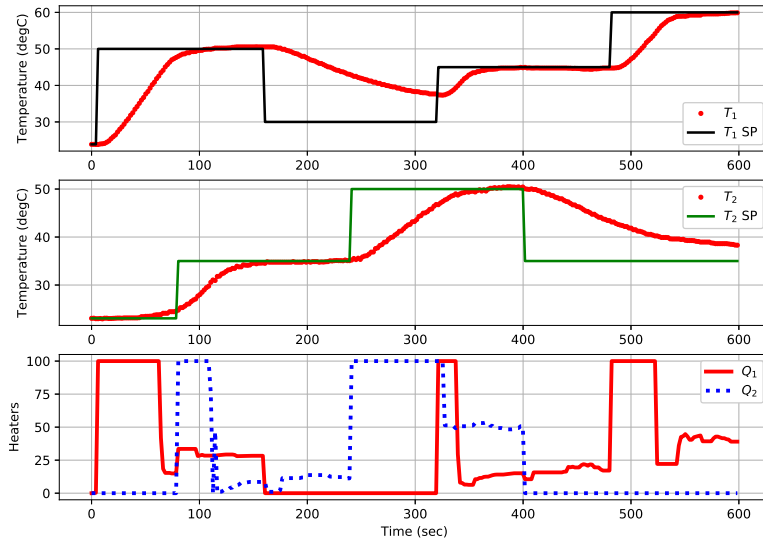


Figure 15: MPC with Physics-based Model

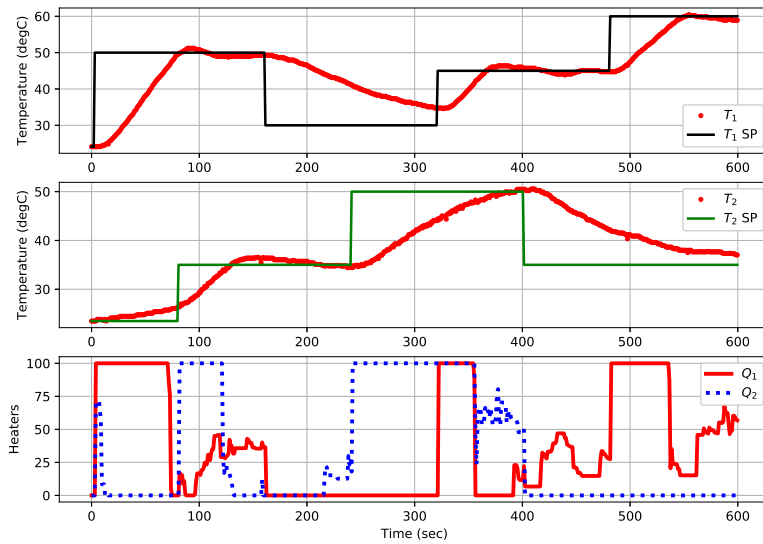


Figure 16: MPC with ARX Time Series Model

391 increased cycling due to model mismatch. The ARX MPC has slight overshoot
392 due to the underestimation of process gain that leads to overly aggressive MV
393 movement as shown in Figure 17.

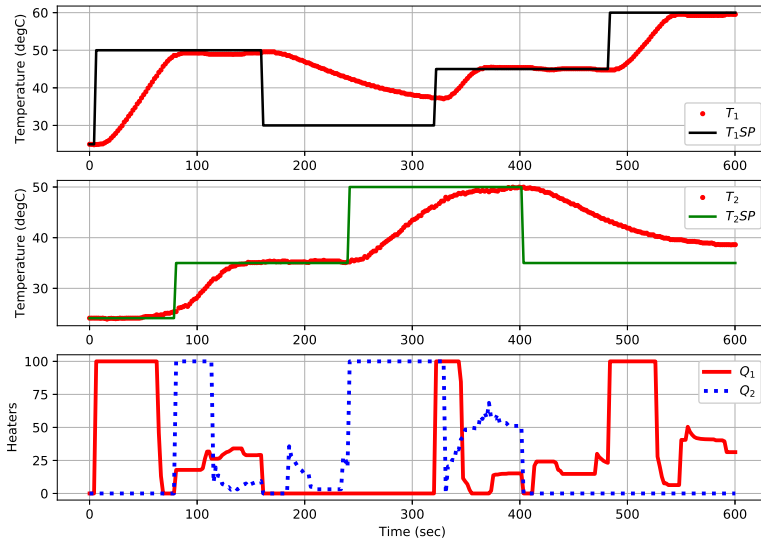


Figure 17: MPC with Hammerstein ANN Model

394 The Hammerstein MPC has the potential to excel in situations where the
395 process is highly nonlinear and there is not a suitable physics-based represen-
396 tation of the process. Like the physics-based MPC, it requires a slower 2 sec
397 cycle time to meet the real-time constraint. Unlike the physics-based MPC,
398 it is not expected to perform well when used outside of the training domain.
399 To facilitate the comparison, a repository of source code and Arduino firmware
400 <https://github.com/APMonitor/arduino> is available with all the examples
401 from this paper.

402 **7. Conclusion and Future Work**

403 The benchmark studies included in this paper are a sampling of common
404 modeling and control methods that are quantified with the TCLab shield and
405 an Arduino microcontroller. The temperature response is modeled with four
406 approaches: physics-based, FOPDT, ARX, and Hammerstein ANN with linear
407 dynamics. Separate data sets are used for training and validation. The objective
408 of the modeling is to create automatic controllers with PID and MPC. A PID
409 optimal tuning case study uses an exhaustive search as a straightforward method
410 for closed-loop retuning to improve performance by 5.4%. The optimal PID
411 parameters are selected by replaying past setpoint and load disturbances where
412 the residuals of estimation are considered as the unmeasured load disturbances.
413 A second study is the application of the three multivariate models in MPC with
414 varying degrees of nonlinearity and physics-based foundation.

415 This study presents a sample of potential modeling and control applications
416 that are quantified with the TCLab hardware benchmark. There are additional
417 potential applications for evaluating methods in estimation, data reconciliation,
418 machine learning, classification, fault detection, anomaly detection, disturbance
419 identification and rejection, integration of control and scheduling, mixed inte-
420 ger systems, stability analysis, explicit MPC, and others. Because each TCLab
421 device is slightly different, benchmark evaluations are performed on the same
422 device and with similar ambient conditions. The TCLab is an accessible hard-
423 ware platform for benchmarking models and closed-loop performance with real
424 data.

425 **Acknowledgments**

426 This article is prepared for a Special Issue in honor of Tom Edgar's 75th
427 birthday and to celebrate his lifetime of accomplishments and leadership in the
428 area of Process Systems Engineering. This work is influenced by his work with
429 energy systems, optimization, control engineering education, and advancements

430 in model-based control among many other areas of contribution. We are grateful
431 for his contributions and continued service to the community.

432 **Appendix A. Software Interface to TCLab**

433 Two parts to the software interface are the firmware that runs on the Ar-
434 duino Leonardo and the serial interface to interpret and command the TCLab.
435 An important part of making the benchmark accessible is to create an inter-
436 face to software (MATLAB, Simulink, and Python) where control algorithms
437 are developed but also provide information for interfaces to other software plat-
438 forms. There is an Arduino Support Package for MATLAB and Simulink from
439 MathWorks that automatically loads firmware onto the Arduino when it is con-
440 nected for the first time. The Arduino firmware for Python is an *ino* file that is
441 augmented with additional sections to compile as *c++* code with a gcc compiler
442 through the Arduino IDE. The TCLab is pre-loaded with the Python interface
443 firmware.

444

Listing 1: MATLAB Commands to Adjust Heaters and Display Temperatures

```
445 clear all  
446 % include tclab.m  
447 tclab;  
448 disp('Turn on Heaters and LED')  
449 h1(30); h2(60); led(1);  
450 pause(10)  
451 disp('Display Temperatures')  
452 disp(T1C())  
453 disp(T2C())  
454 h1(0); h2(0); led(0);  
455  
456
```

457

Adjust Heaters With Sliders

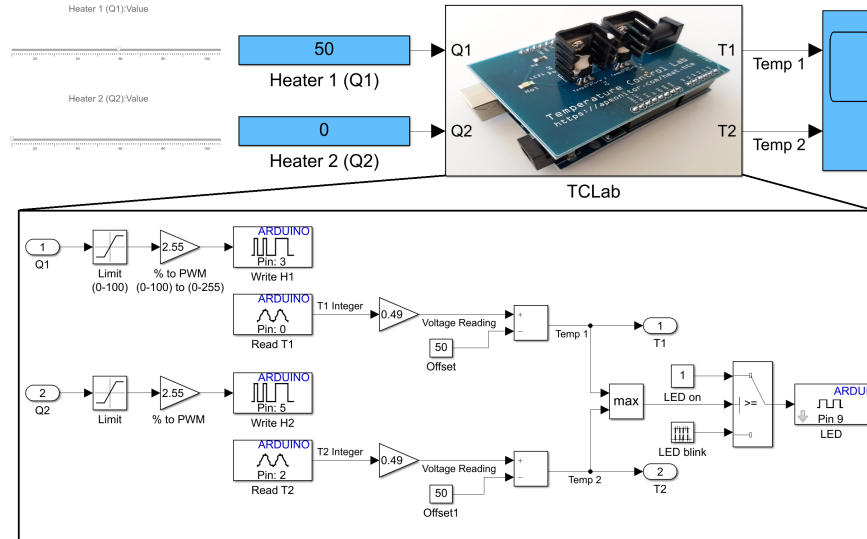


Figure A.18: Simulink Interface with Manual Sliders for Heater Levels.

Listing 2: Python Commands to Adjust Heaters and Display Temperatures

```

458
459 import tclab # pip install tclab
460 import time
461 # Connect to Arduino
462 a = tclab.TCLab()
463 print('Turn on Heaters and LED')
464 a.Q1(30.0); a.Q2(60.0); a.LED(100)
465 time.sleep(10.0)
466 print('Display Temperatures')
467 print(a.T1)
468 print(a.T2)
469 a.close()
470

```

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472 **References**

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